IN THE CLAIMS

Please amend the claims as follows:

Claim 1 (Currently Amended): A substrate processing system for processing substrates, comprising:

integer, each unit group having at least one identical unit for performing processing unit and being configured to perform first to n-th wafer-processing substrate processing for given periods t1 to tn, respectively, the processing being performed in order from the first unit to the n-th unit, a plurality of substrates being simultaneously processed by different types of the processing units for one cycle, the system comprising:

a loading/unloading section for taking in and out the substrates;

a first transfer section for receiving/transferring configured to receive/transfer the substrates from/to the loading/unloading section and transferring to transfer the substrates one by one to [[each]] one of the processing unit groups; and

a controller for controlling the configured to control the first transfer section and the processing units [[so]] such that each processing unit processes the substrates one by one in accordance with one cycle time as a standard time a substrate in a respective process time that is less than or equal to a standard one-cycle time, the one-cycle time being [[the]] a maximum period among periods t1/m to tn/m, m being a positive integer equal to the processing units actually present in each of obtained by dividing the periods t1 to tn by the number "m" of the identical units of the first to n-th processing units unit groups, respectively,[[;]]

wherein the processing time of each processing unit includes a pre-transfer time, a net processing time, a post-transfer time, and a waiting time, and the controller adjusts the processing time of each processing unit in accordance with the one-cycle time.

Claims 2-3 (Canceled).

Claim 4 (Currently Amended): The substrate processing system according to claim

[[3]] 1, wherein the waiting time is times are allocated before or after one of added to the pretransfer time, the net processing time and or the post-transfer time in the processing time
required for each processing unit.

Claims 5-10 (Canceled).

Claim 11 (Original): The substrate processing system according to claim 1, wherein the processing units include at least one thermal processing unit.

Claim 12 (Currently Amended): The substrate processing system according to claim 11, wherein the at least one thermal processing unit [[has]] includes a heating mechanism and a lift-up mechanism for holding configured to distance each substrate so that the substrate is distant from the heating mechanism during the waiting time of the thermal processing unit, the thermal processing unit waiting for thermal processing while the lift-up mechanism is holding the substrate as distant from the heating mechanism.

Claim 13 (Currently Amended): The substrate processing system according to claim 1, wherein the processing units include one developing unit for developing configured to develop a resist applied onto each substrate.

Claim 14 (Currently Amended): The substrate processing system according to claim 1, wherein the processing units include at least one exposing apparatus for exposing configured to expose a resist applied onto each substrate.

Claim 15 (Currently Amended): The substrate processing system according to claim 1, further emprises comprising:

a second transfer section accessible to each of the processing units for transferring and configured to transfer each substrate from one of the processing units to another.

Claim 16 (Currently Amended): A substrate processing system including for processing substrates, comprising:

first to n-th processing units (n = 1, 2, ..., N) unit groups, n being a positive integer, each unit group having at least one identical unit for performing processing unit and being configured to perform first to n-th wafer processing wafer processing for given periods t1 to tn, respectively, the processing being performed in order from the first unit to the n-th unit, a plurality of substrates being simultaneously processed by different type of the processing units for one cycle, the system comprising:

- a loading/unloading section for taking in and out the substrates;
- a first transfer section for receiving/transferring configured to receive/transfer the substrates from/to the loading/unloading section and transferring to transfer the substrates one by one to [[each]] one of the processing unit groups;

a second transfer section for receiving/transferring configured to receive/transfer the substrates from/to the processing units; and

a controller for controlling configured to control the first transfer section, the second transfer section, and the processing units, when the substrates are simultaneously processed by the different types of processing units so such that each processing unit processes the substrates one by one a substrate within a one-cycle time that corresponds at least to either set as the greater of a first total transfer time or a second total transfer time that is larger than the other,

the first total transfer time being the total of periods in the one cycle for of a duration required for the first transfer section required for receiving/transferring each substrate from/to to remove the substrate from the loading/unloading section, transfer the substrate to the one of the processing unit groups, and remove a next substrate from the loading/unloading section and transferring the substrate to each processing unit, and

the second total transfer time being the total of periods in the one cycle for a duration for which the second transfer section required for receiving/transferring the substrate from/to the processing units moves a substrate from one processing unit group to a next processing unit group.

Claim 17 (Currently Amended): The substrate processing system according to claim 16, wherein the controller calculates the maximum period among periods t1/m to tn/m, m being a positive integer equal to the processing units actually present in each obtained by dividing given periods t1 to tn by the number "m" of the identical units of the first to n-th processing units and sets the maximum among the maximum period, unit groups, respectively, and

the first total transfer time and the second transfer time as the one cycle time for controlling the first and the second transfer sections the controller sets the maximum period as the first transfer time or the second transfer time.

Claim 18 (Currently Amended): The substrate processing system according to claim 16, wherein at least one of the processing units is a substrate-receiving unit for receiving and processing configured to receive and process each substrate, and

the controller calculating the total receiving and calculates a processing period time for the substrate-receiving unit for receiving and processing each substrate and setting the maximum among the total receiving and processing period, and sets the processing time of the substrate-receiving unit as the first total transfer time [[and]] or the second total transfer time as the one-cycle time.

Claim 19 (Currently Amended): The substrate processing system according to claim 16, further comprising:

an exposing apparatus; and

a third transfer section for receiving configured to receive the substrates from the processing units and transferring transfer the substrates to the exposing apparatus,

wherein the controller sets the maximum among the first total transfer time, the second total transfer time, and a third total transfer time [[for]] of the third transfer section required for the one cycle, as the one-cycle time.

Claim 20 (Currently Amended): A method of processing substrates with first to n-th processing units (n = 1, 2, ..., N) unit groups, n being a positive integer, each unit group having at least one identical unit for performing processing unit and being configured to

perform first to n-th wafer processing substrate processing for given periods t1 to tn, respectively, the processing being performed in order from the first unit to the n-th unit, a plurality of substrates being simultaneously processed by different types of the processing units for one cycle, the method comprises the steps of comprising:

processing the substrates in each processing unit, one by one, for a respective processing time that is less than or equal to a standard in accordance with one-cycle time as a standard time, the one-cycle time being [[the]] a maximum period among periods t1/m to tn/m, m being a positive integer equal to obtained by dividing the periods t1 to tn by the number "m" of the identical units of the processing units actually present in each of the first to n-th processing units unit groups, respectively,[[; and]]

performing processing to each substrate in at least one of the processing units with unit having a waiting time,

wherein the processing time of each processing unit includes a pre-transfer time, a net processing time, a post-transfer time, and a waiting time, and the controller adjusts the processing time of each processing unit in accordance with the one-cycle time.